

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/608,712 | Applicant(s)/Patent Under Reexamination SUYAMA, AKIHIKO | |
| | Examiner VAN T. PHAM | Art Unit 2627 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | A | US-5,281,797 A | 01-1994 | Tatsuno et al. | 250/201.5 |
| * | B | US-5,809,003 | 09-1998 | Taira et al. | 369/275.1 |
| * | C | US-5,956,311 A | 09-1999 | Kawai, Hideo | 369/100 |
| * | D | US-2001/0040867 | 11-2001 | Onodera et al. | 369/292 |
| * | E | US-6,490,239 | 12-2002 | Nagasaka, Kimio | 369/275.4 |
| * | F | US-6,521,318 B1 | 02-2003 | Li, Yiwei | 428/64.1 |
| * | G | US-2003/0058771 A1 | 03-2003 | Furukawa et al. | 369/59.11 |
| * | H | US-6,735,166 B1 | 05-2004 | Kusafuka et al. | 369/275.3 |
| * | I | US-2004/0125730 | 07-2004 | Yamamoto, Kazutaka | 369/059.24 |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.